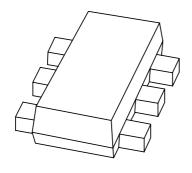
## DISCRETE SEMICONDUCTORS

# DATA SHEET



## PBSS5240V 40 V low V<sub>CEsat</sub> PNP transistor

Product data sheet 2003 Jan 30



## 40 V low V<sub>CEsat</sub> PNP transistor

#### PBSS5240V

#### **FEATURES**

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain (hFE) at high IC
- · High efficiency leading to reduced heat generation
- Reduced printed-circuit board area requirements.

#### **APPLICATIONS**

- Power management:
  - DC-DC converter
  - Supply line switching
  - Battery charger
  - LCD back lighting.
- · Peripheral driver:
  - Driver in low supply voltage applications (e.g. lamps, LEDs)
  - Inductive load drivers (e.g. relay, buzzers and motors).

#### **DESCRIPTION**

PNP transistor providing low  $V_{CEsat}$  and high current capability in a SOT666 plastic package. NPN complement: PBSS4240V.

#### **MARKING**

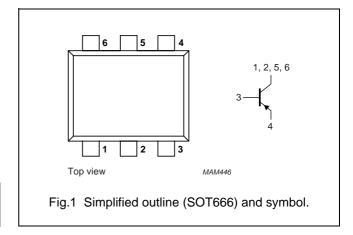
TYPE NUMBER	MARKING CODE
PBSS5240V	52

#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	-40	V
I <sub>C</sub>	collector current (DC)	-1.8	Α
I <sub>CRP</sub>	peak collector current	-2	Α
R <sub>CEsat</sub>	equivalent on-resistance	<250	mΩ

#### **PINNING**

PIN	DESCRIPTION	
1	collector	
2	collector	
3	base	
4	emitter	
5	collector	
6	collector	



## 40 V low V<sub>CEsat</sub> PNP transistor

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#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	-40	V
V <sub>CEO</sub>	collector-emitter voltage	open base	_	-40	V
V <sub>EBO</sub>	emitter-base voltage	open collector	_	-5	V
I <sub>C</sub>	collector current (DC)	note 1	_	-1.8	Α
I <sub>CRP</sub>	peak repetitive collector current	note 2	_	-2	Α
I <sub>CM</sub>	peak collector current		_	-3	Α
I <sub>B</sub>	base current (DC)		_	-300	mA
I <sub>BM</sub>	peak base current		_	-1	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C; note 3	_	300	mW
		T <sub>amb</sub> ≤ 25 °C; note 4	_	500	mW
		T <sub>amb</sub> ≤ 25 °C; note 1	_	900	mW
		T <sub>amb</sub> ≤ 25 °C; notes 2 and 3	_	1.2	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>j</sub>	junction temperature		_	150	°C
T <sub>amb</sub>	operating ambient temperature		-65	+150	°C

#### **Notes**

- 1. Device mounted on a ceramic circuit board, Al<sub>2</sub>O<sub>3</sub>, standard footprint.
- 2. Operated under pulsed conditions: duty cycle  $\delta \leq$  20%, pulse width  $t_p \leq$  30 ms.
- 3. Device mounted on a printed-circuit board, single-sided copper, tinplated, standard footprint.
- 4. Device mounted on a printed-circuit board, single-sided copper, tinplated, mounting pad for collector 1 cm<sup>2</sup>.

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-a</sub>	thermal resistance from junction to	note 1	410	K/W
	ambient	note 2	215	K/W
		note 3	140	K/W
		notes 1 and 4	110	K/W

#### Notes

- 1. Device mounted on a printed-circuit board, single-sided copper, tinplated, standard footprint.
- 2. Device mounted on a printed-circuit board, single-sided copper, tinplated, mounting pad for collector 1 cm<sup>2</sup>.
- 3. Device mounted on a ceramic circuit board, Al<sub>2</sub>O<sub>3</sub>, standard footprint.
- 4. Operated under pulsed conditions: duty cycle  $\delta \leq$  20%, pulse width  $t_p \leq$  30 ms.

#### Soldering

The only recommended soldering method is reflow soldering.

## 40 V low $V_{\text{CEsat}}$ PNP transistor

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#### **CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

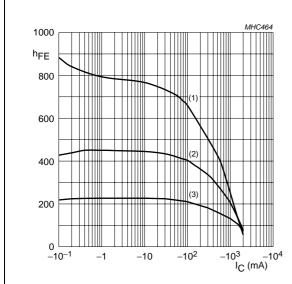
SYMBOL	PARAMETER	CONDITIONS		TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = -40 \text{ V}; I_E = 0$	_	_	-100	nA
		V <sub>CB</sub> = -40 V; I <sub>E</sub> = 0; T <sub>amb</sub> = 150 °C	_	_	-50	μΑ
I <sub>CEO</sub>	collector-emitter cut-off current	$V_{CE} = -30 \text{ V}; I_B = 0$	_	_	-100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0$	_	_	-100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	300	_	_	
		$V_{CE} = -5 \text{ V}; I_{C} = -100 \text{ mA}$	300	_	800	
		$V_{CE} = -5 \text{ V}; I_{C} = -500 \text{ mA}$	250	_	_	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	160	_	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -2 \text{ A}; \text{ note 1}$	50	_	_	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_C = -100 \text{ mA}; I_B = -1 \text{ mA}$	_	-80	-120	mV
		$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	_	-100	-145	mV
		$I_C = -1 \text{ A}; I_B = -100 \text{ mA}; \text{ note 1}$	_	-180	-250	mV
		$I_C = -2 \text{ A}; I_B = -200 \text{ mA}$	_	-370	-530	mV
R <sub>CEsat</sub>	equivalent on-resistance	$I_C = -1 \text{ A}$ ; $I_B = -100 \text{ mA}$ ; note 1	-	180	<250	mΩ
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = -1 \text{ A}; I_B = -100 \text{ mA}$	-	_	-1.1	V
V <sub>BEon</sub>	base-emitter turn-on voltage	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	_	_	-1	V
f⊤	transition frequency	$I_C = -50 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 100 MHz	150	_	_	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = I_e = 0; f = 1 \text{ MHz}$	_	-	12	pF

#### Note

1. Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 

## 40 V low V<sub>CEsat</sub> PNP transistor

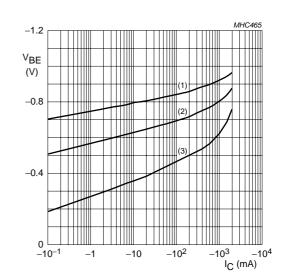
## PBSS5240V



 $V_{CE} = -5 \text{ V}.$ 

- (1)  $T_{amb} = 150 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55$  °C.

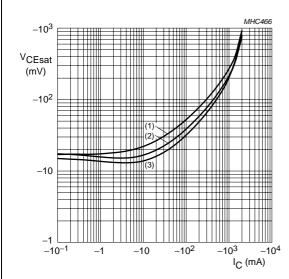
Fig.2 DC current gain as a function of collector current; typical values.



 $V_{CE} = -5 \text{ V}.$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2) T<sub>amb</sub> = 25 °C.
- (3)  $T_{amb} = 150 \, ^{\circ}C$ .

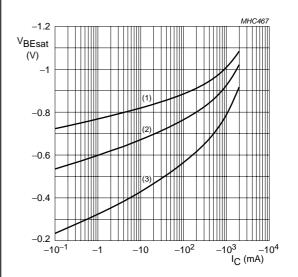
Fig.3 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = 150 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.4 Collector-emitter saturation voltage as a function of collector current; typical values.



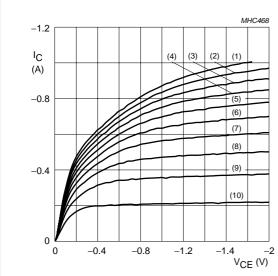
 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 150 \, ^{\circ}C$ .

Fig.5 Base-emitter saturation voltage as a function of collector current; typical values.

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 $T_{amb}$  = 25 °C.

(1)  $I_B = -7 \text{ mA}$ .

(5)  $I_B = -4.2 \text{ mA}.$ 

(9)  $I_B = -1.4 \text{ mA}.$ 

(2)  $I_B = -6.3 \text{ mA}.$ 

(6)  $I_B = -3.5 \text{ mA}.$ 

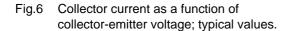
(10)  $I_B = -0.7 \text{ mA}.$ 

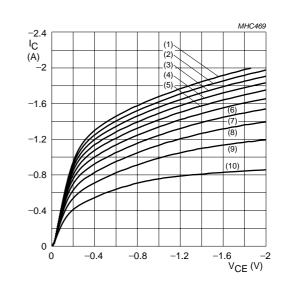
(3)  $I_B = -5.6 \text{ mA}.$ 

(7)  $I_B = -2.8 \text{ mA}.$ 

(4)  $I_B = -4.9 \text{ mA}$ .

(8)  $I_B = -2.1 \text{ mA}.$ 





 $T_{amb}$  = 25 °C.

(1)  $I_B = -50 \text{ mA}.$ 

(5)  $I_B = -30 \text{ mA}.$ 

(9)  $I_B = -10 \text{ mA}.$ 

(2)  $I_B = -45 \text{ mA}.$ 

(6)  $I_B = -25 \text{ mA}.$ 

(10)  $I_B = -5 \text{ mA}$ .

(3)  $I_B = -40 \text{ mA}.$ (4)  $I_B = -35 \text{ mA}.$  (7)  $I_B = -20 \text{ mA}.$ (8)  $I_B = -15 \text{ mA}.$ 

Fig.7 Collector current as a function of collector-emitter voltage; typical values.

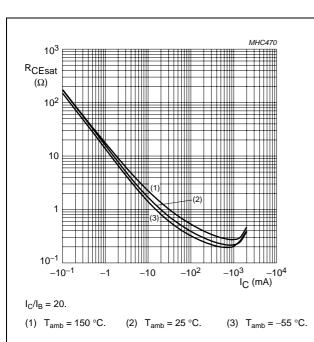


Fig.8 Collector-emitter equivalent on-resistance as a function of collector current; typical values.

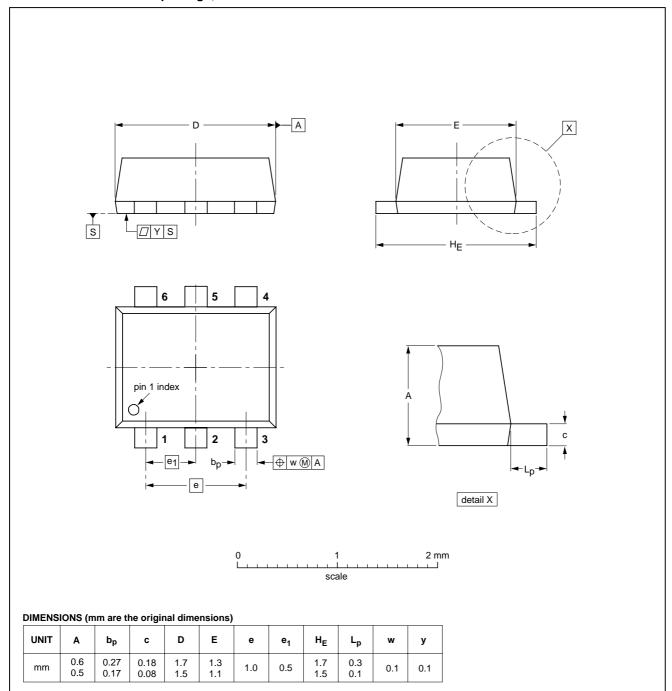
## 40 V low V<sub>CEsat</sub> PNP transistor

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#### **PACKAGE OUTLINE**

Plastic surface mounted package; 6 leads

**SOT666** 



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT666						<del>01-01-04</del> 01-08-27

## 40 V low V<sub>CEsat</sub> PNP transistor

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DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
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Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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